

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10585766	ONISHI ET AL.
	Examiner	Art Unit
	Emmanuel S Luk	1791

SEARCHED			
Class	Subclass	Date	Examiner
425	149, 150, 582, 583	8/3/08	EL
366	78	8/3/08	EL

SEARCH NOTES			
Search Notes	Date	Examiner	
EAST text search	8/3/08	EL	
Reviewed PCT/JP04/19409, parent PCT case at WIPO website along with translated documents	8/3/08	EL	
inventor search	8/3/08	EL	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner